

MOSFET – P-Channel, QFET®

-100 V, -16.5 A, 190 mΩ

FQP17P10

General Description

This P-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

- -16.5 A, -100 V, $R_{DS(on)} = 190 \text{ m}\Omega$ (Max.) at $V_{GS} = -10 \text{ V}$, $I_D = -8.25 \text{ A}$
- Low Gate Charge (Typ. 30 nC)
- Low C_{rss} (Typ. 100 pF)
- 100% Avalanche Tested
- 175°C Maximum Junction Temperature Rating
- This is a Pb-Free Device

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

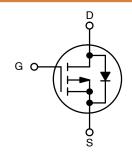
Symbol	Parameter		Ratings	Unit	
V _{DSS}	Drain-Source \	-100	V		
I _D	Drain Current	rain Current Continuous (T _C = 25°C)		Α	
		Continuous (T _C = 100°C)	-11.7		
I _{DM}	Drain Current	Pulsed (Note 1)	-66	Α	
V _{GSS}	SS Gate-Source Voltage			V	
E _{AS}	Single Pulse Av	580	mJ		
I _{AR}	Avalanche Curi	-16.5	Α		
E _{AR}	Repetitive Aval	10	mJ		
dv/dt	Peak Diode Re	Peak Diode Recovery dv/dt (Note 3)			
P _D	Power	(T _C = 25°C)	100	W	
	Dissipation	Derate above 25°C	0.67	W/°C	
T_J, T_{STG}	Operating and Range	–55 to +175	°C		
TL	Maximum Lead Soldering, 1/8"	300	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

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- 1. Repetitive rating: pulse-width limited by maximum junction temperature
- 2. L = 3.2 mH, I_{AS} = -16.5 A, V_{DD} = -25 V, R_G = 25 Ω , Starting T_J = 25° C 3. I_{SD} ≤ -16.5 A, di/dt ≤ 300 A/ μ s, V_{DD} $\leq BV_{DSS}$, Starting T_J = 25° C

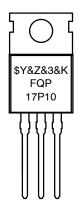
V _{DS}	R _{DS(ON)} MAX	I _D MAX
–100 V	0.19 Ω @ -10 V	-16.5 A



P-Channel MOSFET



MARKING DIAGRAM



\$Y = onsemi Logo &Z = Assembly Plant Code = Data Code (Year & Week) &K = Lot Code

FQP17P10 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
FQP17P10	TO-220-3LD (Pb-Free)	50 Units/ Tube

THERMAL CHARACTERITICS

Symbol Parameter		Ratings	Unit
$R_{ heta JC}$	Maximum Thermal Resistance, Junction to Case	1.5	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink, Typ.	0.5	°C/W
$R_{\theta JA}$	Maximum Thermal Resistance, Junction to Ambient	62.5	°C/W

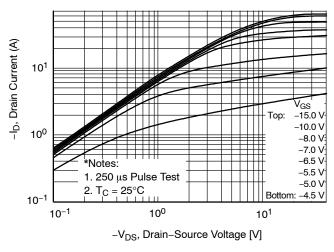
ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Unit
FF CHARA	ACTERISTICS	•	•			
BV _{DSS}	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V, } I_D = -250 \mu\text{A}$	-100	-	_	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I _D = -250 μA, Referenced to 25°C	_	-0.1	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -100 V, V _{GS} = 0 V	-	-	-1	μΑ
		$V_{DS} = -80 \text{ V}, T_{C} = 150 ^{\circ}\text{C}$	_	-	-10	
I _{GSSF}	Gate -Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$	_	-	-100	nA
I _{GSSR}	Gate -Body Leakage Current, Reverse	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
N CHARA	CTERISTICS					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	-2.0	-	-4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -8.25 \text{ A}$	-	0.14	0.19	Ω
9FS	Forward Transconductance	$V_{DS} = -40 \text{ V}, I_D = -8.25 \text{ A}$	-	9.9	-	S
YNAMIC C	HARACTERISTICS	•	•			
C _{iss}	Input Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	_	850	1100	pF
C _{oss}	Output Capacitance	1 -	-	310	400	pF
C _{rss}	Reverse Transfer Capacitance	7	-	100	130	pF
WITCHING	CHARACTERISTICS	•	•	•		
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -50 \text{ V, } I_{D} = -16.5 \text{ A,}$ $R_{G} = 25 \Omega$ (Note 4)	_	17	45	ns
t _r	Turn-On Rise Time		_	200	410	ns
t _{d(off)}	Turn-Off Delay Time		_	45	100	ns
t _f	Turn-Off Fall Time		-	100	210	ns
Qg	Total Gate Charge	V _{DS} = -80 V, I _D = -16.5 A,	-	30	39	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V (Note 4)	_	4.8	_	nC
Q _{gd}	Gate-Drain Charge		_	17	_	nC
RAIN-SOU	RCE DIODE CHARACTERISTICS AND M	AXIMUM RATINGS	•			
I _S	Maximum Continuous Drain-Source Diode Forward Current		-	_	-16.5	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Fo	ce Diode Forward Current		-	-66	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = -16.5 A	-	_	-4.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_{S} = -16.5 \text{ A,}$	-	120	-	ns
Q _{rr}	Reverse Recovery Charge	dl _F /dt = 100 A/μs	_	0.52	_	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

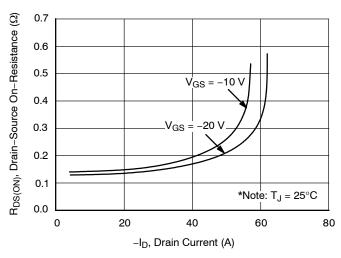


10-1 2 4 6 8 10

-V_{GS}, Gate–Source Voltage (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



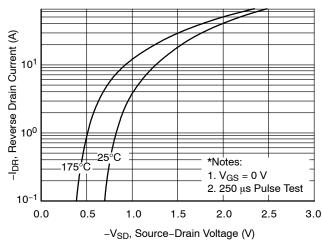
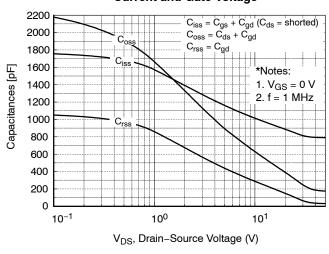


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature



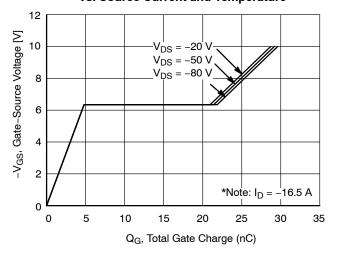


Figure 5. Capacitance Characteristics

Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (continued)

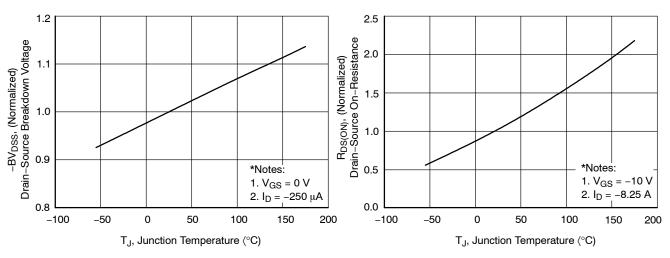


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On–Resistance Variation vs. Temperature

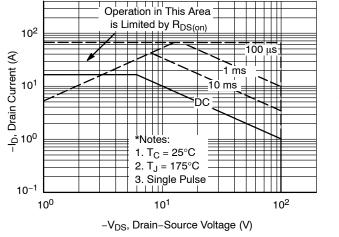


Figure 9. Maximum Safe Operating Area

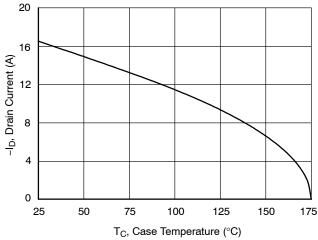


Figure 10. Maximum Drain Current vs. Case Temperature

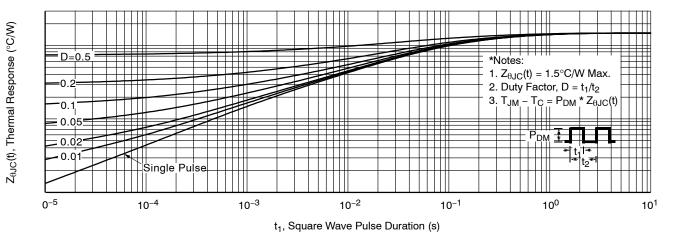


Figure 11. Transient Thermal Response Curve

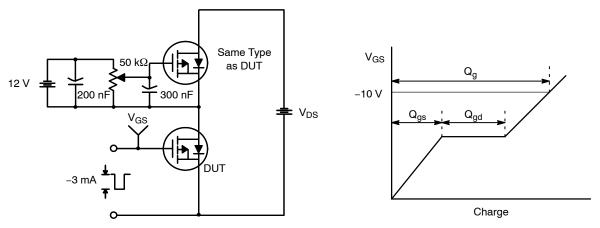


Figure 12. Gate Charge Test Circuit & Waveform

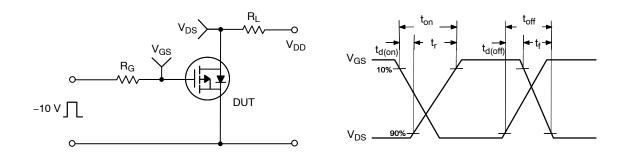


Figure 13. Resistive Switching Test Circuit & Waveforms

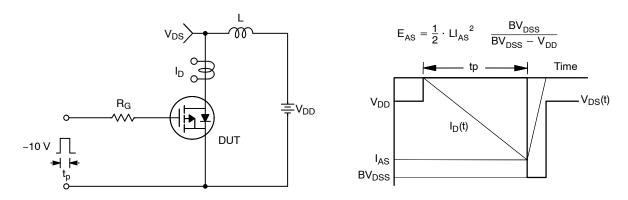


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

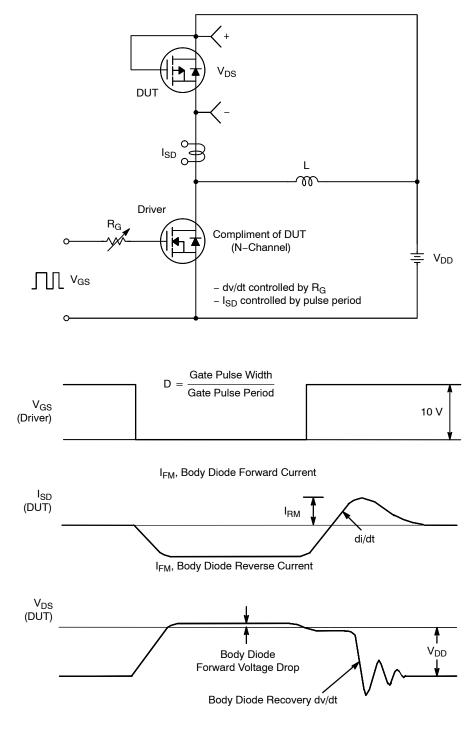
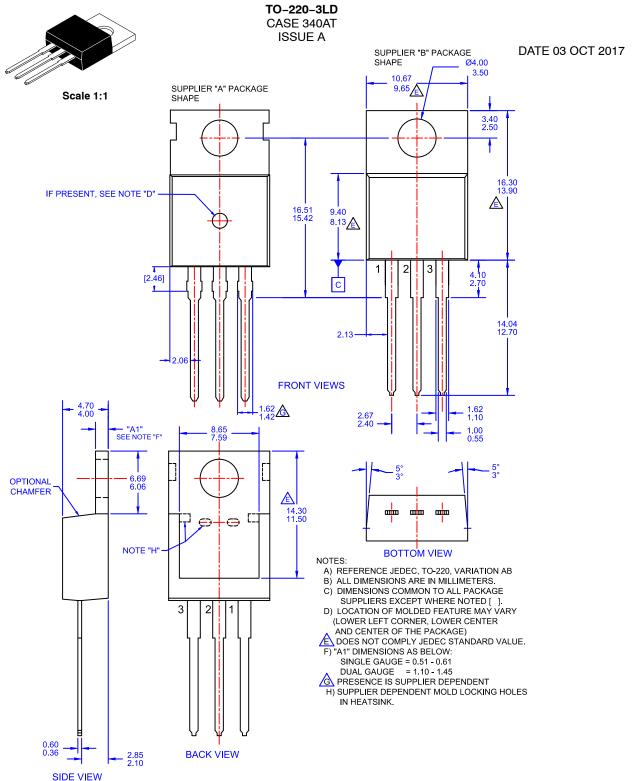


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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